## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | HSIEH ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,709,883	03-2004	Yang et al.	438/47
*	В	US-6,693,352	02-2004	Huang et al.	257/743
*	С	US-2002/0036296	03-2002	Akaike et al.	257/102
*	D	US-2003/0047737	03-2003	Lin et al.	257/79
*	E	US-2003/0143772	07-2003	Chen, Tzer-Perng	438/47
	F	US-6,522,063	02-2003	Chen et al.	313/498
*	G	US-6,503,831	01-2003	Speakman, Stuart	438/674
*	Н	US-6,563,139	05-2003	Hen, Chang Hsiu	257/89
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			·

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					,
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

TOTAL								
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	<b>v</b>							
	w							
	х							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.